











CSD16570Q5B

SLPS496A - JULY 2014-REVISED MAY 2017

# CSD16570Q5B 25-V N-Channel NexFET™ Power MOSFET

#### **Features**

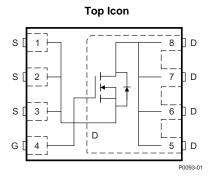
- Extremely Low Resistance
- Low  $Q_q$  and  $Q_{qd}$
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- **RoHS Compliant**
- Halogen Free
- SON 5-mm × 6-mm Plastic Package

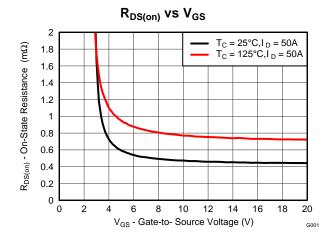
## **Applications**

ORing and Hot Swap Applications

### 3 Description

This 25 V, 0.49 mΩ, SON 5 x 6 mm NexFET™ power MOSFET is designed to minimize resistance for ORing and hot swap applications and is not designed for switching applications.





#### **Product Summary**

$T_A = 25^\circ$	С	TYPICAL VA	UNIT				
$V_{DS}$	Drain-to-Source Voltage	25		٧			
$Q_g$	Gate Charge Total (4.5 V) 95						
$Q_{gd}$	Gate Charge Gate-to-Drain	31	nC				
R <sub>DS(on)</sub>	Drain-to-Source On-Resistance	V <sub>GS</sub> = 4.5 V 0.68		mΩ			
	Drain-to-Source On-Resistance	V <sub>GS</sub> = 10 V 0.49		mΩ			
V <sub>GS(th)</sub>	Threshold Voltage	1.5	V				

### Ordering Information<sup>(1)</sup>

Device	Qty	Media	Media Package			
CSD16570Q5B	2500	13-Inch Reel	SON 5 x 6 mm	Tape and		
CSD16570Q5BT	250	7-Inch Reel	Plastic Package	Reel		

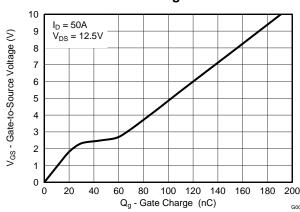
(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### **Absolute Maximum Ratings**

7 110 0 1 110 1 1 1 1 1 1 1 1 1 1 1 1 1								
$T_A = 2$	5°C	VALUE	UNIT					
$V_{DS}$	Drain-to-Source Voltage	25	V					
$V_{GS}$	Gate-to-Source Voltage	±20	٧					
I <sub>D</sub>	Continuous Drain Current (Package limited)	100						
	Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$	456	Α					
	Continuous Drain Current <sup>(1)</sup>	59						
I <sub>DM</sub>	Pulsed Drain Current <sup>(2)</sup>	400	Α					
0	Power Dissipation <sup>(1)</sup>	3.2	W					
$P_D$	Power Dissipation, T <sub>C</sub> = 25°C	195						
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	-55 to 150	°C					
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D = 98 \text{ A}, L = 0.1 \text{ mH}, R_G = 25 \Omega$	480	mJ					

- (1) Typical  $R_{\theta JA}=40^{\circ}\text{C/W}$  on a 1-inch $^2$  , 2-oz. Cu pad on a 0.06-inch thick FR4 PCB.
- (2) Max  $R_{\theta,IC} = 0.8$ °C/W, Pulse duration  $\leq 100 \mu s$ , duty cycle  $\leq 1\%$

#### **Gate Charge**





# **Table of Contents**

1 Features 1   2 Applications 1   3 Description 1   4 Revision History 2   5 Specifications 3   5.1 Electrical Characteristics 3   5.2 Thermal Information 3   5.3 Typical MOSFET Characteristics 4   6 Device and Documentation Support 7   6.1 Receiving Notification of Documentation Updates 7	6.2 Community Resources
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# 4 Revision History

Cł	changes from Original (July 2014) to Revision A					
•	Added the Receiving Notification of Documentation Updates and Community Resource sections to Device and Documentation Support.	7				
•	Changed the dimension between pads 3 and 4 from 0.028 inches: to 0.050 inches in the Recommended PCB Pattern section diagram	9				



# 5 Specifications

#### 5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC (	CHARACTERISTICS				
BV <sub>DSS</sub>	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25		V
I <sub>DSS</sub>	Drain-to-Source Leakage Current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V		1	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V		100	nA
V <sub>GS(th)</sub>	Gate-to-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.1 1.5	1.9	V
D	Drain-to-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 50 \text{ A}$	0.68	0.82	mΩ
R <sub>DS(on)</sub>	Dialii-to-Source Ori-Resistance	$V_{GS} = 10 \text{ V}, I_D = 50 \text{ A}$	0.49	0.59	$m\Omega$
9 <sub>fs</sub>	Transconductance	$V_{DS} = 2.5 \text{ V}, I_D = 50 \text{ A}$	278		S
DYNAMIC	C CHARACTERISTICS				
C <sub>iss</sub>	Input Capacitance		10700	14000	рF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0 \text{ V}, V_{DS} = 12 \text{ V}, f = 1 \text{ MHz}$	1660	2160	рF
C <sub>rss</sub>	Reverse Transfer Capacitance		996	1290	pF
$R_{G}$	Series Gate Resistance		1.8	3.6	Ω
$Q_g$	Gate Charge Total (4.5 V)		95	124	nC
$Q_g$	Gate Charge Total (10 V)		192	250	nC
$Q_{gd}$	Gate Charge Gate-to-Drain	$V_{DS} = 12.5 \text{ V}, I_D = 50 \text{ A}$	31		nC
$Q_{gs}$	Gate Charge Gate-to-Source		29		nC
Q <sub>g(th)</sub>	Gate Charge at V <sub>th</sub>		15		nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 12.5 V, V <sub>GS</sub> = 0 V	35		nC
t <sub>d(on)</sub>	Turn On Delay Time		5		ns
t <sub>r</sub>	Rise Time	V <sub>DS</sub> = 12.5 V, V <sub>GS</sub> = 10 V,	43		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$I_{DS} = 50 \text{ A}, R_G = 0 \Omega$	156		ns
t <sub>f</sub>	Fall Time		72		ns
DIODE C	HARACTERISTICS				
V <sub>SD</sub>	Diode Forward Voltage	I <sub>SD</sub> = 50 A, V <sub>GS</sub> = 0 V	0.8	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DS</sub> = 12.5 V, I <sub>F</sub> = 50 A,	34		nC
t <sub>rr</sub>	Reverse Recovery Time	di/dt = 300A/μs	21		ns

#### 5.2 Thermal Information

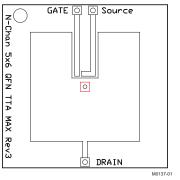
 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance <sup>(1)</sup>			0.8	°C/W
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance <sup>(1)(2)</sup>			50	C/VV

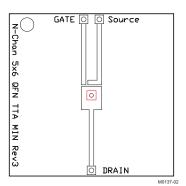
<sup>(1)</sup> R<sub>θJC</sub> is determined with the device mounted on a 1-inch² (6.45-cm²), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inches x 1.5-inches (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R<sub>θJC</sub> is specified by design, whereas R<sub>θJA</sub> is determined by the user's board design.

(2) Device mounted on FR4 material with 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu.





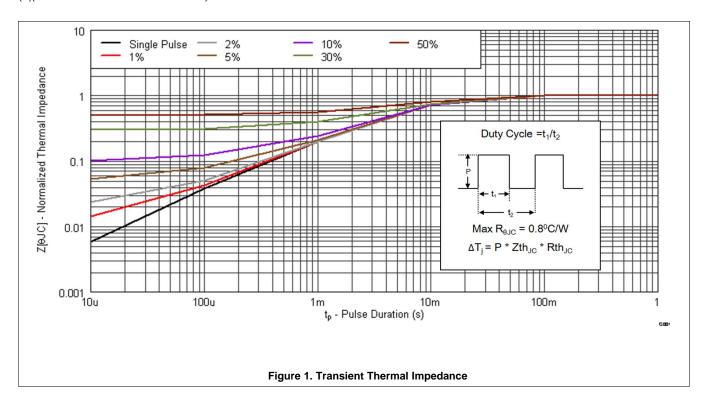
Max  $R_{\theta JA} = 50^{\circ} C/W$  when mounted on 1 inch² (6.45 cm²) of 2-oz. (0.071-mm thick) Cu.



Max  $R_{\theta JA} = 125^{\circ} C/W$  when mounted on a minimum pad area of 2-oz. (0.071-mm thick) Cu.

## 5.3 Typical MOSFET Characteristics

(T<sub>A</sub> = 25°C unless otherwise stated)





10

8

7

6 5 4

2

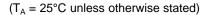
0

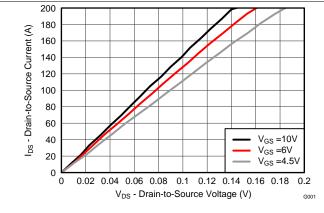
20 40 60 80

 $I_{D} = 50 \text{ A}$ 

V<sub>GS</sub> - Gate-to-Source Voltage (V)

## **Typical MOSFET Characteristics (continued)**





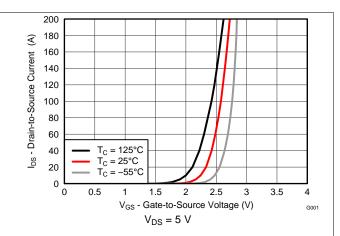


Figure 2. Saturation Characteristics

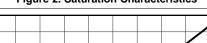


Figure 3. Transfer Characteristics

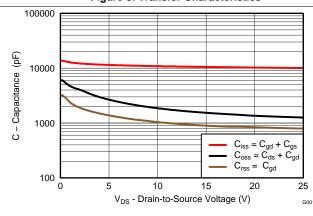


Figure 4. Gate Charge

Q<sub>g</sub> - Gate Charge (nC)

100 120 140

 $V_{DS} = 12.5 \text{ V}$ 

160 180

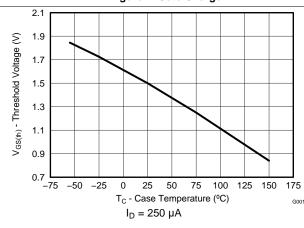


Figure 5. Capacitance

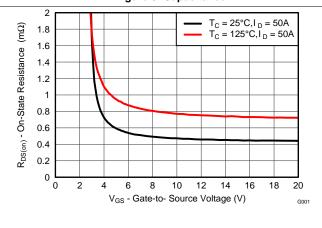


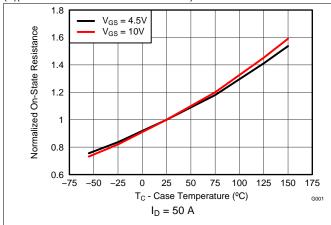
Figure 6. Threshold Voltage vs Temperature

Figure 7. On-State Resistance vs Gate-to-Source Voltage



### **Typical MOSFET Characteristics (continued)**

(T<sub>A</sub> = 25°C unless otherwise stated)



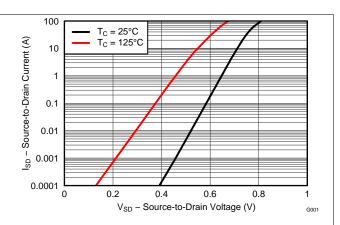
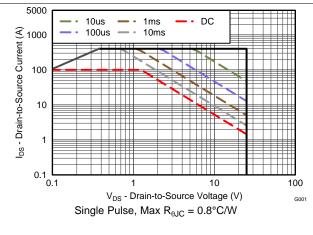


Figure 8. Normalized On-State Resistance vs Temperature





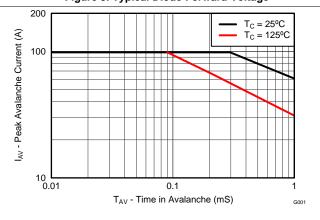


Figure 10. Maximum Safe Operating Area

Figure 11. Single Pulse Unclamped Inductive Switching

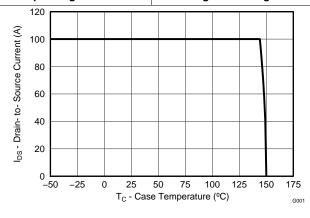


Figure 12. Maximum Drain Current vs Temperature



## 6 Device and Documentation Support

#### 6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 6.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 6.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments.

#### 6.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 6.5 Glossary

SLYZ022 — TI Glossary.

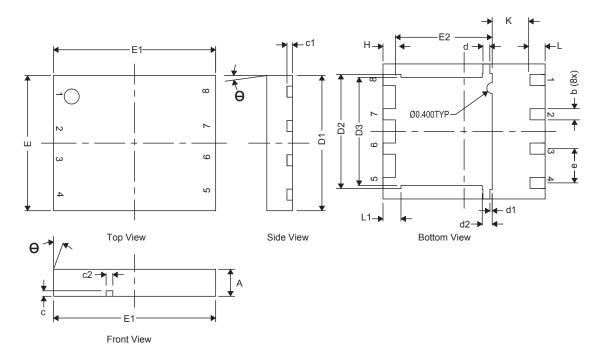
This glossary lists and explains terms, acronyms, and definitions.



# 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

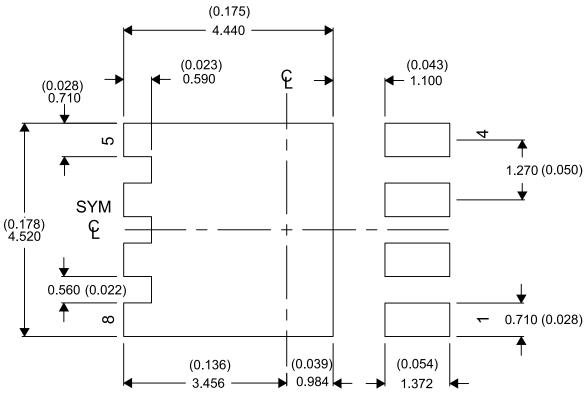
#### 7.1 Q5B Package Dimensions



DIM	MILLIMETERS							
DIM	MIN	NOM	MAX					
A	0.80	1.00	1.05					
b	0.36	0.41	0.46					
С	0.15	0.20	0.25					
c1	0.15	0.20	0.25					
c2	0.20	0.25	0.30					
D1	4.90	5.00	5.10					
D2	4.12	4.22	4.32					
D3	3.90	3.90 4.00						
d	0.20	0.30						
d1		0.085 TYP						
d2	0.319	0.369	0.419					
E	4.90	5.00	5.10					
E1	5.90	6.00	6.10					
E2	3.48	3.58	3.68					
е		1.27 TYP	•					
Н	0.36	0.46	0.56					
L	0.46 0.56		0.66					
L1	0.57	0.67	0.77					
θ	0°	_	_					
К	1.40 TYP							

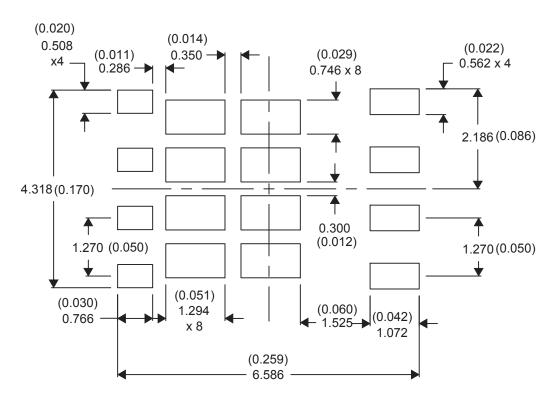


#### 7.2 Recommended PCB Pattern



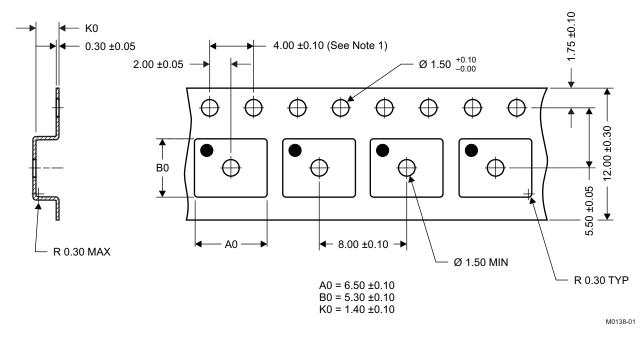
For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

## 7.3 Recommended Stencil Pattern





#### 7.4 Q5B Tape and Reel Information



#### Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm
- 3. Material: black static-dissipative polystyrene
- 4. All dimensions are in mm (unless otherwise specified).
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket.

## PACKAGE OPTION ADDENDUM



10-Dec-2020

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CSD16570Q5B	ACTIVE	VSON-CLIP	DNK	8	2500	RoHS-Exempt & Green	NIPDAU   SN	Level-1-260C-UNLIM	-55 to 150	CSD16570	Samples
CSD16570Q5BT	ACTIVE	VSON-CLIP	DNK	8	250	RoHS-Exempt & Green	NIPDAU   SN	Level-1-260C-UNLIM	-55 to 150	CSD16570	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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